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**Key:** IEEE JNL = IEEE Journal or Magazine, IEE JNL = IEE Journal or Magazine, IEEE CNF = IEEE Conference, IEE CNF = IEE Conference, IEEE STD = IEEE Standard

1. **Analysis of a statistics counter architecture**  
Devavrat Shah; Sundar Iyer; Balaji Prabhakar; McKeown, N.;  
Hot Interconnects 9, 2001.  
22-24 Aug. 2001 Page(s):107 - 111  
IEEE CNF
2. **A data-centric concurrency control mechanism for three tier systems**  
Janaki Ram, D.; Chandra Sekhar, N.S.K.; Uma Mahesh, M.;  
Systems, Man, and Cybernetics, 2001 IEEE International Conference on  
Volume 4, 7-10 Oct. 2001 Page(s):2402 - 2407 vol.4  
IEEE CNF
3. **A Josephson ternary memory circuit**  
Morisue, M.; Endo, J.; Morooka, T.; Shimizu, N.; Sakamoto, M.;  
Multiple-Valued Logic, 1998. Proceedings. 1998 28th IEEE International Symposium on  
27-29 May 1998 Page(s):19 - 24  
IEEE CNF
4. **On the design of optimal counter-based schemes for test set embedding**  
Kagaris, D.; Tragoudas, S.;  
Computer-Aided Design of Integrated Circuits and Systems, IEEE Transactions on  
Volume 18, Issue 2, Feb. 1999 Page(s):219 - 230  
IEEE JNL
5. **Interaction depth in CdTe/CdZnTe spectrometers by electron drift time**  
Li, W.; He, Z.; Knoll, G.F.; Wehe, D.K.;  
Nuclear Science Symposium Conference Record, 2000 IEEE  
Volume 1, 15-20 Oct. 2000 Page(s):4/30 vol.1  
IEEE CNF
6. **A gamma-ray imager with multiplexer readout for use in ultra-high-resolution brain SPECT**  
Barber, H.B.; Barrett, H.H.; Dereniak, E.L.; Hartsough, N.E.; Perry, D.L.; Rogulski, M.M.; Woolfenden, J.M.; Young, E.T.; Roberts, P.C.T.;  
Nuclear Science Symposium and Medical Imaging Conference, 1992., Conference Record of the 1992 IEEE  
25-31 Oct. 1992 Page(s):1104 - 1106 vol.2  
IEEE CNF